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**ON Semiconductor®** 

# BSS138-F085 N-Channel Logic Level Enhancement Mode Field Effect Transistor

# **General Description**

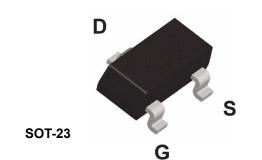
These N-Channel enhancement mode field effect transistors are produced using Fairchild's proprietary, high cell density, DMOS technology. These products have been designed to minimize on-state resistance while provide rugged, reliable, and fast switching performance. These products are particularly suited for low voltage, low current applications such as small servo motor control, power MOSFET gate drivers, and other switching applications.

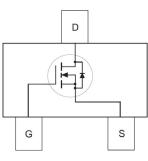
### Features

- Automotive Qualified
- 0.22 A, 50 V. RDS(ON) = 3.5Ω @ VGS = 10 V

RDS(ON) = 6.0Ω @ VGS = 4.5 V

- High density cell design for extremely low RDS(ON)
- Rugged and Reliable
- Compact industry standard SOT-23 surface mount package





# **Absolute Maximum Rations**

T<sub>A</sub> = 25°C unless otherwise noted

Symbol	Parameter		Units	Symbol	
V <sub>DSS</sub>	Drain-Source Voltage		50	V	
V <sub>GSS</sub>	Gate-Source Voltage		±20	V	
I <sub>D</sub>	Drain Current – Continuous	(Note 1)	0.22	Α	
	– Pulsed		0.88	A	
P <sub>D</sub>	Maximum Power Dissipation	(Note 1)	0.36	W	
	Derate Above 25°C		2.8	mW/°C	
T <sub>J</sub> , T <sub>STG</sub>	Operating and Storage Junction Temperatur	-55 to +150	°C		
Τ <sub>L</sub>	Maximum Lead Temperature for Soldering F 1/16" from Case for 10 Seconds	300	°C		
Thermal C	haracteristics			·	
R <sub>0JA</sub>	Thermal Resistance, Junction-to-Ambient	(Note 1)	350	°C/W	

Device Marking	Device	Reel Size	Tape width	Quantity	
SS	BSS138-F085	7"	8mm	3000 units	

Symbol	Parameter	Test Conditions	Min	Тур	Max	Unit
Off Cha	aracteristics					
BV <sub>DSS</sub>	Drain–Source Breakdown Voltage	V <sub>GS</sub> = 0 V,  I <sub>D</sub> = 250 μA	50			V
ΔBVdss / ΔTj	Breakdown Voltage Temperature Coefficient	I <sub>D</sub> = 250 μA, Referenced to 25°C		72		mV/°C
		V <sub>DS</sub> = 50V, V <sub>GS</sub> = 0 V			0.5	μA
I <sub>DSS</sub>	Zero Gate Voltage Drain Current	V <sub>DS</sub> = 50V, V <sub>GS</sub> = 0 V, T <sub>J</sub> = 125°C			5	μA
		V <sub>DS</sub> = 30V, V <sub>GS</sub> = 0 V			100	nA
I <sub>GSS</sub>	Gate-Body Leakage	$V_{GS} = \pm 20V, V_{DS} = 0V$			±100	nA

### $V_{DS} = V_{GS}$ , 1.5 I<sub>D</sub> = 1 mA 0.8 1.3 V<sub>GS(th)</sub> Gate Threshold Voltage $\Delta V_{GS(th)}$ Gate Threshold Voltage I<sub>D</sub> = 1 mA, Referenced to 25°C -2 $/\Delta T_J$ **Temperature Coefficient** V<sub>GS</sub> = 10 V, I<sub>D</sub> = 0.22 A 0.7 3.5 V<sub>GS</sub> = 4.5 V, I<sub>D</sub> = 0.22 A Static Drain-Source On-Resistance 1.0 6.0 R<sub>DS(on)</sub> $V_{GS}$ = 10 V, $I_{D}$ = 0.22 A, $T_{J}$ = 125°C 1.1 5.8 V<sub>GS</sub> = 10 V, V<sub>DS</sub> = 5 V I<sub>D(on)</sub> On-State Drain Current 0.2 V<sub>DS</sub> = 10 V, I<sub>D</sub> = 0.22 A

# **Dynamic Characteristics**

C <sub>iss</sub>	Input Capacitance	V <sub>DS</sub> = 25 V, f = 1.0 MHz	V <sub>GS</sub> = 0 V,	27	pF
C <sub>oss</sub>	Output Capacitance			13	pF
C <sub>rss</sub>	Reverse Transfer Capacitance			6	pF
R <sub>G</sub>	Gate Resistance	Vgs = 15 mV,	f = 1.0 MHz	9	Ω

### Switching Characteristics (Note2)

Forward Transconductance

t <sub>d(on)</sub>	Turn-On Delay Time		I <sub>D</sub> = 0.29 A, R <sub>GEN</sub> = 6 Ω	2.8	5.8	ns
t <sub>r</sub>	Turn-On Rise Time	V <sub>DD</sub> = 30 V,		2.1	4.4	ns
t <sub>d(off)</sub>	Turn-Off Delay Time	V <sub>GS</sub> = 10 V,		9.6	19.2	ns
t <sub>f</sub>	Turn-Off Fall Time			8.4	16.8	ns
Qg	Total Gate Charge		I <sub>D</sub> = 0.22 A,	1.7	2.4	nC
Q <sub>gs</sub>	Gate-Source Charge	V <sub>DS</sub> = 25 V, V <sub>GS</sub> = 10 V		0.1		nC
Q <sub>gd</sub>	Gate-Drain Charge	VGS IV		0.4		nC

# **Drain–Source Diode Characteristics and Maximum Ratings**

ls	Maximum Continuous Drain–Source Diode Forward Current					0.22	А
Vsd	Drain–Source Diode Forward Voltage	V <sub>GS</sub> = 0 V,	I <sub>S</sub> = 0.44 A	(Note 2)	0.8	1.4	V

Notes:

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**g**fs

1. Rula is the sum of the junction-to-case and case-to-ambient thermal resistance where the case thermal reference is defined as the solder mounting surface of the drain pins.  $R_{\mbox{\tiny BJC}}$  is guaranteed by design while  $R_{\mbox{\tiny BJA}}$  is determined by the user's board design.

a) 350°C/W when mounted on a minimum pad. ð Scale 1 : 1 on letter size paper

2. Pulse Test: Pulse Width  $\leq$  300  $\mu s,$  Duty Cycle  $\leq$  2.0%

V

mV/°C

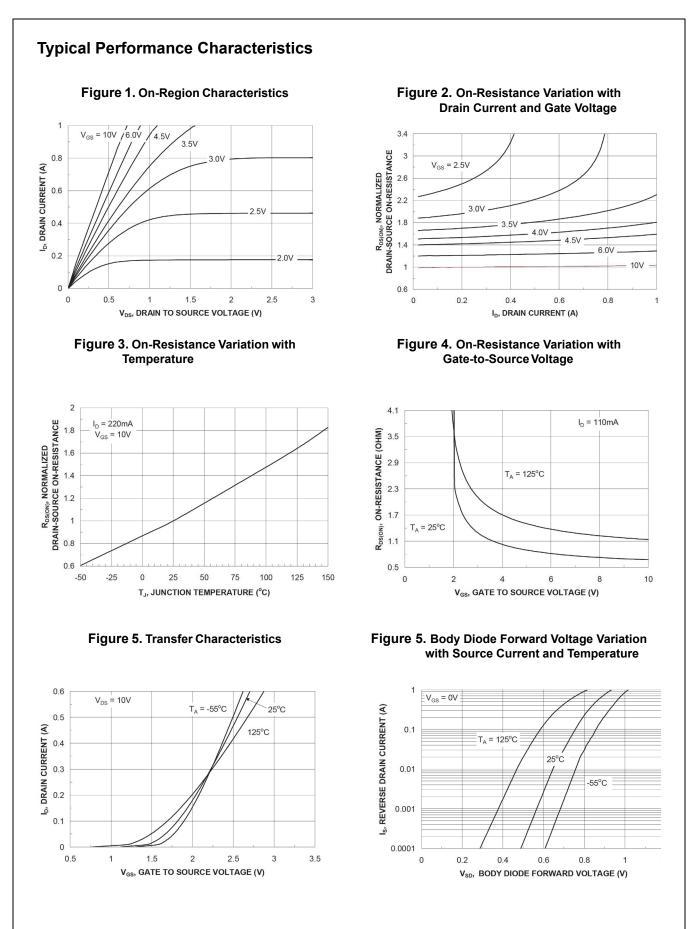
Ω

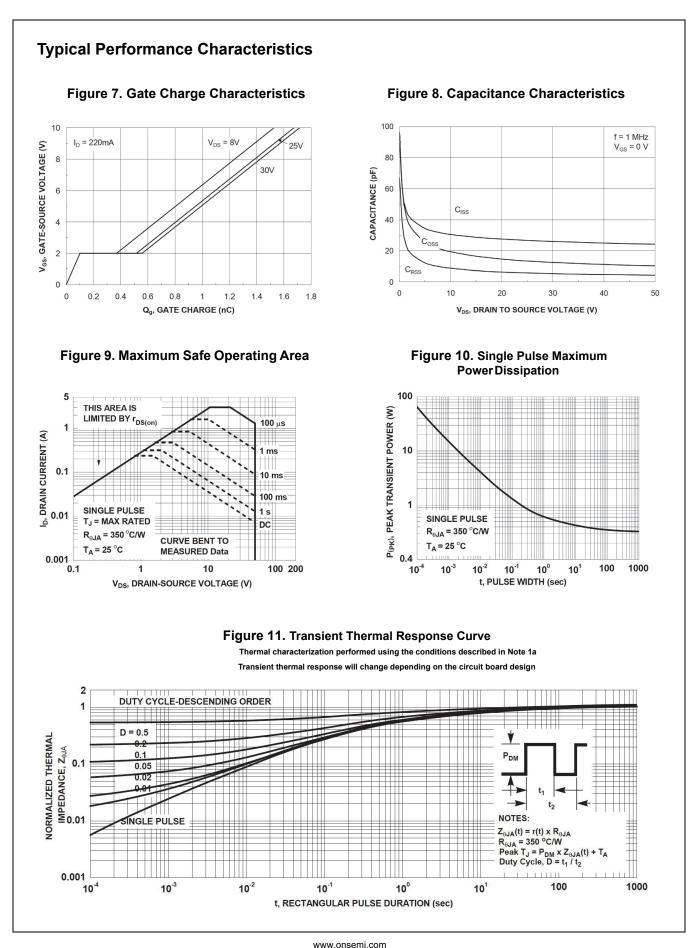
А

S

0.12

0.5





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